# **Power MOSFET**

# –20 V, –9.4 A, μCool<sup>™</sup> Single P–Channel, ESD, 2.0x2.0x0.55 mm UDFN Package

## Features

- UDFN Package with Exposed Drain Pads for Excellent Thermal Conduction
- Low Profile UDFN 2.0x2.0x0.55 mm for Board Space Saving
- Lowest RDS(on) in 2.0x2.0 Package
- ESD Protected
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

## Applications

- High Side Load Switch
- PA Switch and Battery Switch
- Optimized for Power Management Applications for Portable Products, such as Cell Phones, PMP, DSC, GPS, and others

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Pai	Symbol	Value	Units		
Drain-to-Source Voltage			V <sub>DSS</sub>	-20	V
Gate-to-Source Vol	tage		V <sub>GS</sub>	±8.0	V
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I <sub>D</sub>	-6.4	А
Current (Note 1)	State	$T_A = 85^{\circ}C$		-4.6	
	t ≤ 5 s	T <sub>A</sub> = 25°C		-9.4	
Power Dissipa- tion (Note 1)	Steady State	T <sub>A</sub> = 25°C	PD	1.7	W
	t ≤ 5 s	T <sub>A</sub> = 25°C		3.8	
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I <sub>D</sub>	-4.0	А
Current (Note 2)	State	$T_A = 85^{\circ}C$	1	-2.9	
Power Dissipation (	PD	0.7	W		
Pulsed Drain Curre	nt	tp = 10 μs	I <sub>DM</sub>	-30	А
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C
Source Current (Body Diode) (Note 2)			۱ <sub>S</sub>	-1.0	А
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C
ESD Rating (HBM) per JESD22-A114F			ESD	>2000	V

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).

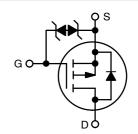
 Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm<sup>2</sup>, 2 oz. Cu.



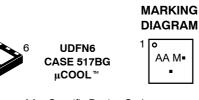
# **ON Semiconductor®**

#### http://onsemi.com

MOSFET						
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX I <sub>D</sub> MAX					
	29 mΩ @ –4.5 V					
–20 V	39 mΩ @ −2.5 V	-9.4 A				
20 1	60 mΩ @ −1.8 V	0.477				
	120 mΩ @ −1.5 V					

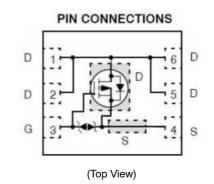


P-Channel MOSFET





(Note: Microdot may be in either location)



#### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

#### THERMAL RESISTANCE RATINGS

Parameter		Max	Units
Junction-to-Ambient – Steady State (Note 3)	$R_{\thetaJA}$	72	°C/W
Junction-to-Ambient – t $\leq$ 5 s (Note 3)	$R_{\thetaJA}$	33	
Junction-to-Ambient – Steady State min Pad (Note 4)	$R_{ hetaJA}$	189	

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Co	ondition	Min	Тур	Max	Units
OFF CHARACTERISTICS		•					
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I	<sub>D</sub> = -250 μA	-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = -250 μA	A, ref to 25°C		-5.0		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$			-1.0	μA
		$V_{\rm DS} = -20$ V	T <sub>J</sub> = 85°C			-10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, \	/ <sub>GS</sub> = ±8.0 V			±10	μA
ON CHARACTERISTICS (Note 5)							-
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS},$	I <sub>D</sub> = -250 μA	-0.4		-1.0	V
Negative Threshold Temp. Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				3.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -6.4 \text{ A}$ $V_{GS} = -2.5 \text{ V}, \text{ I}_{D} = -4.8 \text{ A}$ $V_{GS} = -1.8 \text{ V}, \text{ I}_{D} = -2.5 \text{ A}$ $V_{GS} = -1.5 \text{ V}, \text{ I}_{D} = -1.5 \text{ A}$			23	29	mΩ
					31	39	
					43	60	
					60	120	
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = -15 \	∕, I <sub>D</sub> = −4.0 A		18		S
CHARGES, CAPACITANCES & GATE	RESISTANCE						
Input Capacitance	C <sub>ISS</sub>				2600		pF
Output Capacitance	C <sub>OSS</sub>		, f = 1 MHz, = −15 V		200		
Reverse Transfer Capacitance	C <sub>RSS</sub>	•05 -			190		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -15 \text{ V};$ $I_D = -4.0 \text{ A}$			29		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				1.4		
Gate-to-Source Charge	Q <sub>GS</sub>				3.7		
Gate-to-Drain Charge	Q <sub>GD</sub>				8.1		
SWITCHING CHARACTERISTICS, VG	S = 4.5 V (Note 6)	-		-			
Turn-On Delay Time	t <sub>d(ON)</sub>				9.0		ns
Rise Time	t.				18		

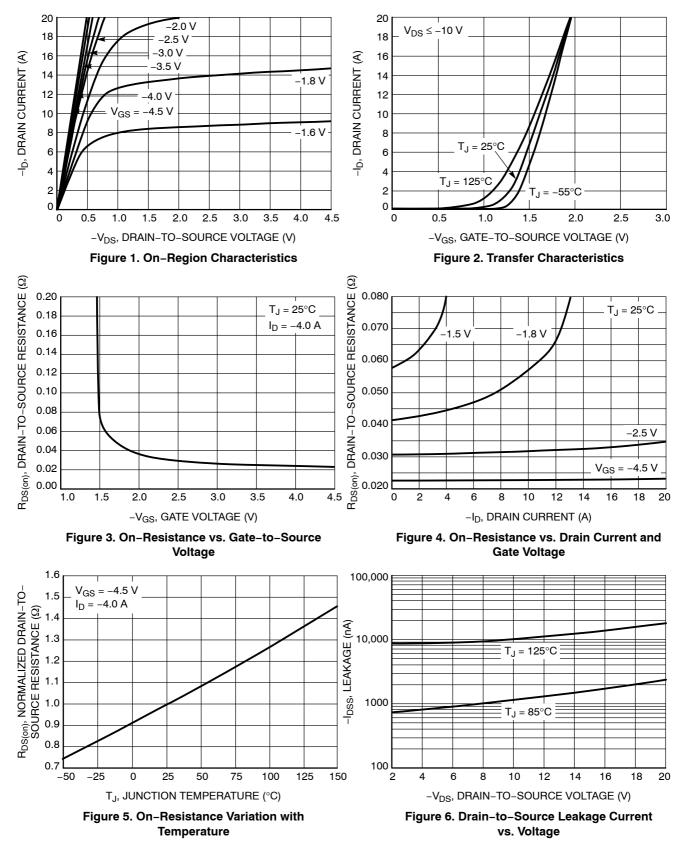
Tull-Off Delay Tille	<sup>L</sup> a(ON)		3.0	110
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = -4.5 V, V <sub>DD</sub> = -15 V,	18	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = -4.0 \text{ A}, \text{ R}_G = 1 \Omega$	126	
Fall Time	t <sub>f</sub>		71	

#### **DRAIN-SOURCE DIODE CHARACTERISTICS**

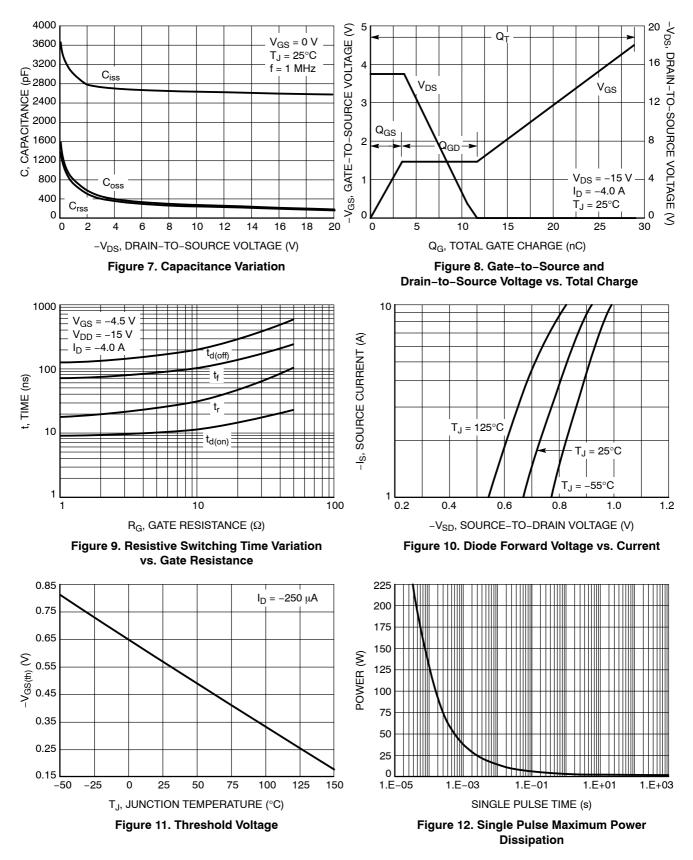
Forward Diode Voltage	VSD	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$	0.65	1.0	V
		V <sub>GS</sub> = 0 V, I <sub>S</sub> = –1.0 A	T <sub>J</sub> = 125°C	0.55		
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dis/dt = 100 A/µs, I <sub>S</sub> = −1.0 A		25		ns
Charge Time	t <sub>a</sub>			10		
Discharge Time	t <sub>b</sub>			15		
Reverse Recovery Charge	Q <sub>RR</sub>	1		13.6		nC

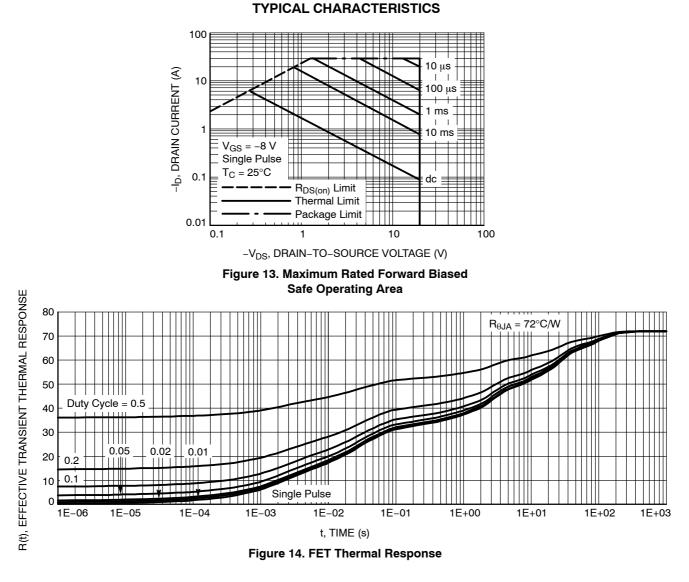
3. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces). 4. Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm<sup>2</sup>, 2 oz. Cu. 5. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%. 6. Switching characteristics are independent of operating junction temperatures.

## **TYPICAL CHARACTERISTICS**



## **TYPICAL CHARACTERISTICS**



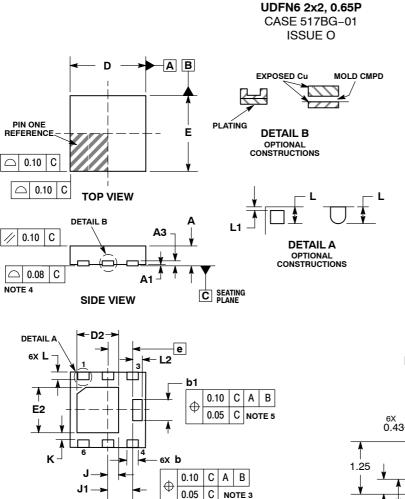


#### **DEVICE ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTLUS3A40PZTAG	UDFN6 (Pb-Free)	3000 / Tape & Reel
NTLUS3A40PZTBG	UDFN6 (Pb-Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS



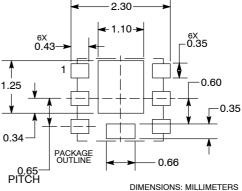
**BOTTOM VIEW** 

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: MILLIMETERS.
- CONTROLLING DIMENSION: MILLIMETERS.
  DIMENSION b APPLIES TO PLATED TERMINAL AND IS
- MEASURED BETWEEN 0.15 AND 0.30 mm FROM TERMINAL 4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
   CENTER TERMINAL LEAD IS OPTIONAL CENTER TERMINAL
- CENTER TERMINAL LEAD IS OPTIONAL. CENTER TERMINAL IS CONNECTED TO TERMINAL LEAD # 4.
   LEADS 1, 2, 5 AND 6 ARE TIED TO THE FLAG.

6. LEAD	LEADS 1, 2, 5 AND 6 ARE TIE					
	MI	MILLIMETERS				
DIN	1 MI	N	MAX			
Α	0.4	5	0.55			
A1	0.0	0	0.05			
A3		0.13	REF			
b	0.2	5	0.35			
b1	0.5	1	0.61			
D		2.00 BSC				
D2	1.0	1.00 1.2				
E		2.00 BSC				
E2	1.1	0	1.30			
е		0.65	BSC			
K		0.15	REF			
J		0.27	BSC			
J1		0.65 BSC				
L	0.2	0	0.30			
L1		-	0.10			
L2	0.2	0	0.30			

#### RECOMMENDED MOUNTING FOOTPRINT



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